



Description

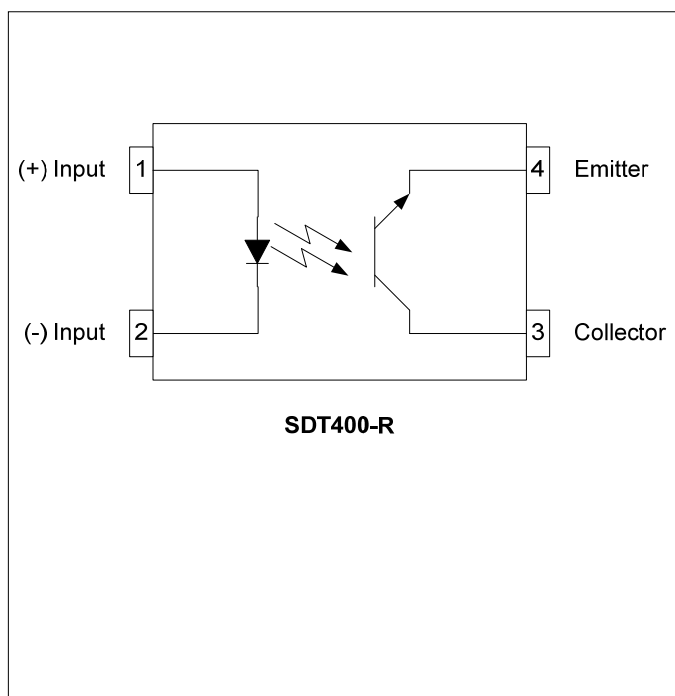
The SDT400-R consists of a phototransistor optically coupled to a light emitting diode. Optical coupling between the input IR LED and output phototransistor allows for high isolation levels while maintaining low-level DC signal control capability. The SDT400-R provides an optically isolated method of controlling many interface applications such as telecommunications, industrial control and instrumentation circuitry.

The SDT400-R comes standard in a miniature 4 pin DIP package.

Applications

- Registers, Copiers, Automatic Vending Machines
- System Appliances, Measuring Instruments
- Computer Terminals, PLCs
- Telecommunication Equipment, Telephones
- Home Appliances
- Digital Logic Inputs
- Microprocessor Inputs
- Switching Power Supplies

Schematic Diagram



Features

- $V_{CEO} = 80V$
- Reversed Output (Emitter-Pin4, Collector-Pin3)
- Low input power consumption
- CTR Range 50 – 600% (Binning Available)
- High Isolation Voltage (5000V_{RMS})
- Long Life / High Reliability
- RoHS / Pb-Free / REACH Compliant

Agency Approvals

UL/C-UL: File # E201932
 VDE: File # 40035191 (EN 60747-5-2)

Absolute Maximum Ratings

The values indicated are absolute stress ratings. Functional operation of the device is not implied at these or any conditions in excess of those defined in electrical characteristics section of this document. Exposure to absolute Maximum Ratings may cause permanent damage to the device and may adversely affect reliability.

Storage Temperature-55 to +125°C
 Operating Temperature-40 to +85°C
 Continuous Input Current.....50mA
 Transient Input Current.....500mA
 Reverse Input Control Voltage6V
 Input Power Dissipation.....70mW
 Total Power Dissipation200mW
 Solder Temperature – Wave (10sec).....260°C
 Solder Temperature – IR Reflow (10sec).....260°C

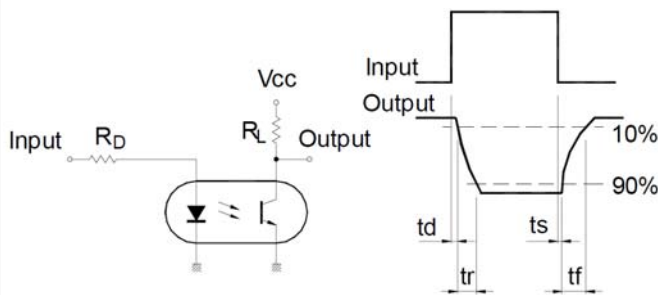
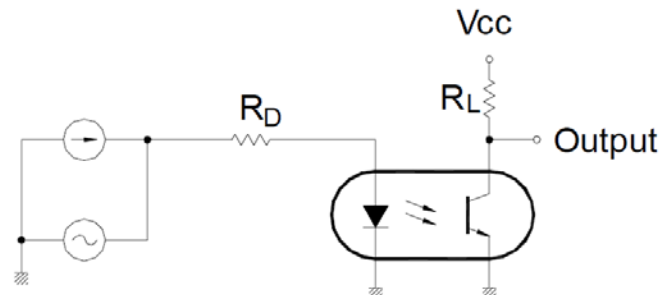
Ordering Information / Lead Form / Packaging

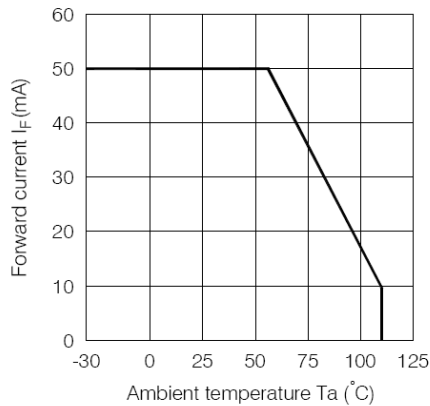
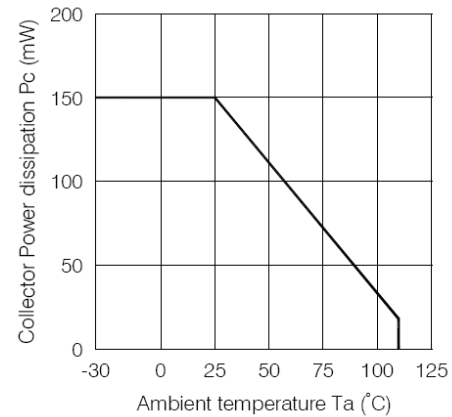
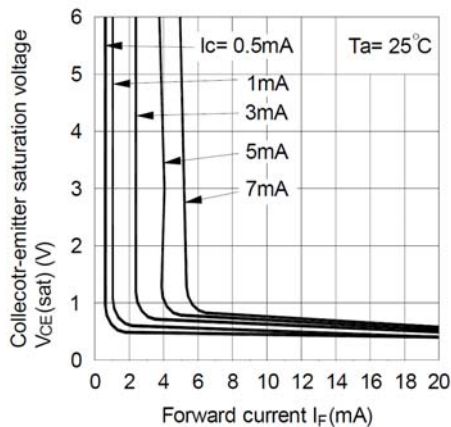
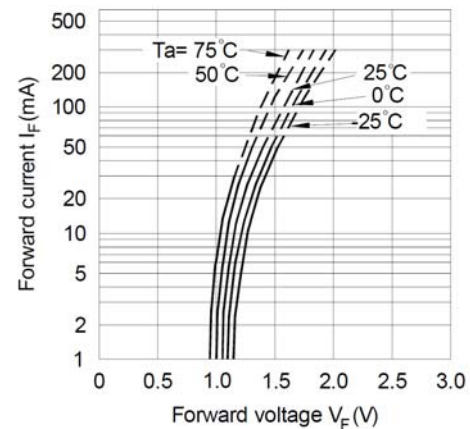
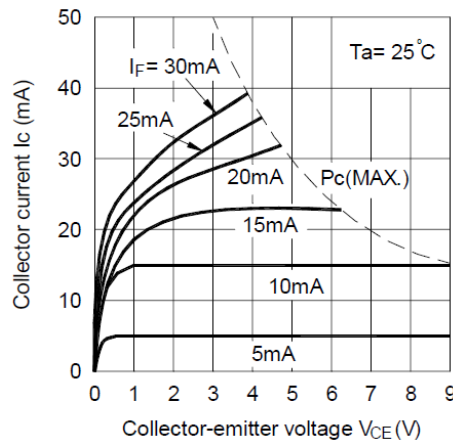
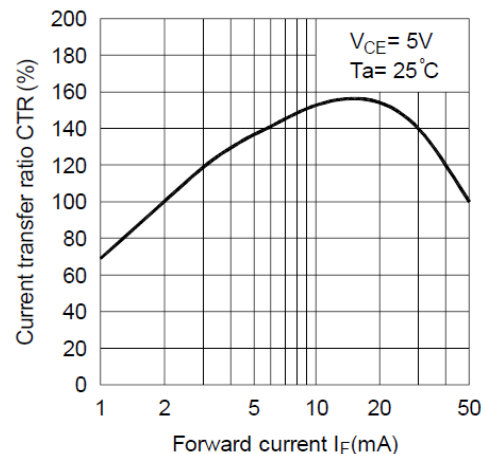
Part Number	Description
SDT400-R	4 pin DIP, (100/Tube)
SDT400-RH	0.40" (10.16mm) Lead Spacing (VDE0884)
SDT400-RS	4 pin SMD, (100/Tube)
SDT400-RSTR	4 pin SMD, Tape and Reel (2000/Reel)

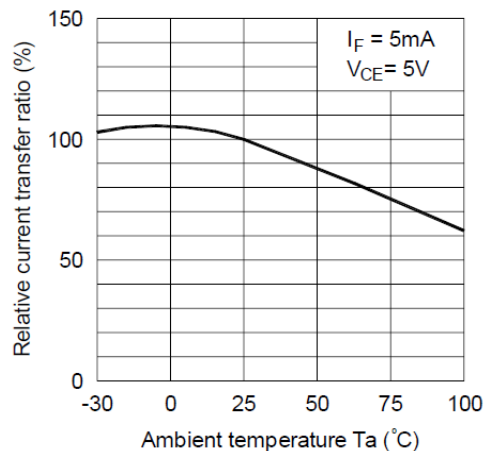
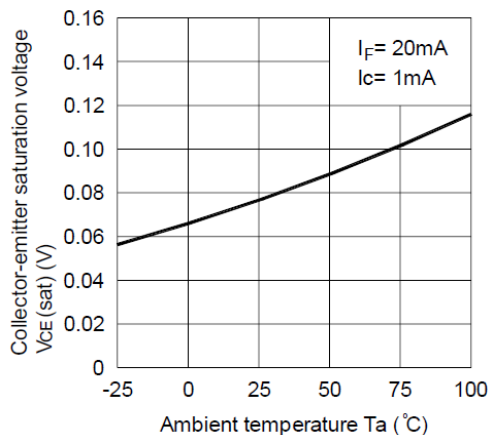
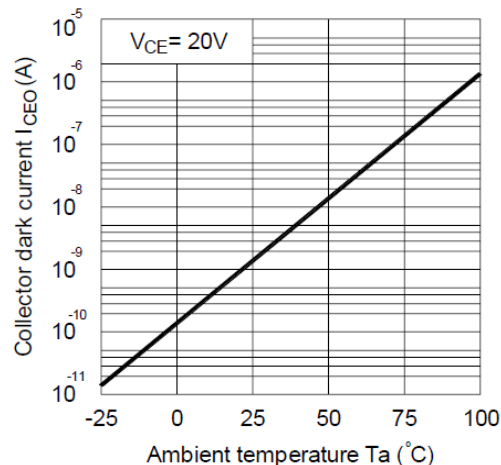
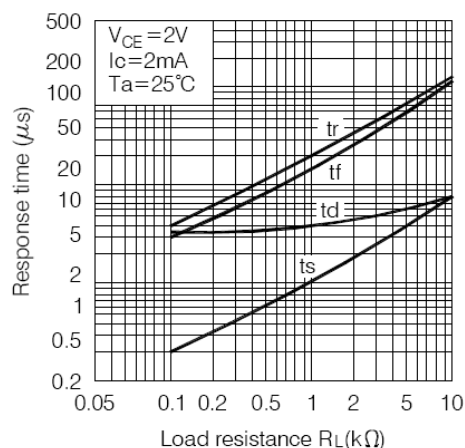
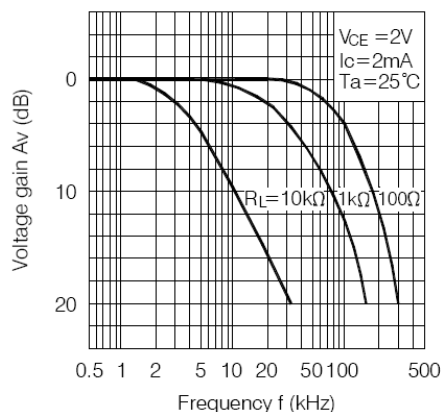
NOTE: For complete product ordering / naming conventions, reference page 10. Suffixes listed above are not included in marking on device for part number identification

Electrical Characteristics, $T_A = 25^\circ\text{C}$ (unless otherwise specified)

Parameter	Symbol	Min.	Typ.	Max.	Units	Test Conditions
Input Specifications						
LED Forward Voltage	V_F	-	1.2	1.4	V	$I_F = 20\text{mA}$
LED Reverse Voltage	BV_R	6	-	-	V	$I_R = 10\mu\text{A}$
Terminal Capacitance	C_t	-	30	250	pF	$V=0, f=1\text{KHz}$
Input Reverse Current	I_R	-	-	10	μA	$V_R=4\text{V}$
Output Specifications						
Collector-Emitter Voltage	V_{CEO}	80	-	-	V	$I_C=100\mu\text{A}$
Emitter-Collector Voltage	V_{ECO}	6	-	-	V	$I_E=10\mu\text{A}$
Collector Dark Current	I_{CEO}	-	-	100	nA	$V_{CE}=20\text{V}$
Collector Current	I_C	2.5	-	30	mA	$I_F=5\text{mA}, V_{CE}=5\text{V}$
Floating Capacitance	C_f	-	0.6	1.0	pF	$V_{CE}=0, f=1\text{MHz}$
Cut-Off Frequency	f_c	-	80	-	kHz	$V_{CE}=5\text{V}, I_C=2\text{mA}, R_L=100\Omega, -3\text{dB}$
Saturation Voltage	$V_{CE(sat)}$	-	0.1	0.2	V	$I_F=20\text{mA}, I_C=1\text{mA}$
Coupled Specifications						
Rise Time	T_R	-	4	-	μS	$I_C=2\text{mA}, V_{CC}=2\text{V}, R_L=100\Omega$
Fall Time	T_F	-	3	-	μS	$I_C=2\text{mA}, V_{CC}=2\text{V}, R_L=100\Omega$
Current Transfer Ratio	CTR	50	-	600	%	$I_F=10\text{mA}, V_{CE}=5\text{V}$
CTR Classification (BINNING)						
- C		100	-	400	%	$I_F=10\text{mA}, V_{CE}=5\text{V}$
- E		50	-	600	%	$I_F=10\text{mA}, V_{CE}=5\text{V}$
Isolation Specifications						
Isolation Voltage	V_{ISO}	5000	-	-	V_{RMS}	$RH \leq 50\%, t=1\text{min}$
Input-Output Resistance	R_{I-O}	-	10^{12}	-	Ω	$V_{I-O} = 500V_{DC}$

Test Circuit: Response Time

Test Circuit: Frequency Response


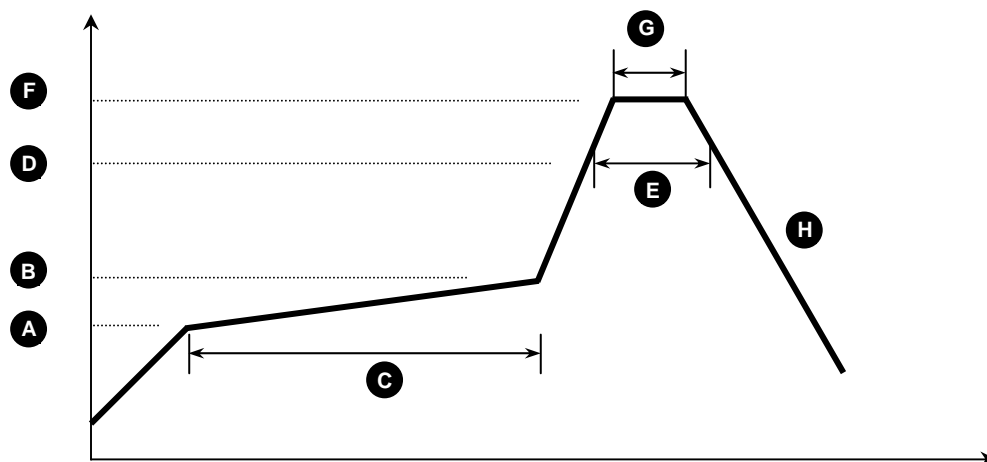
SDT400-R Performance & Characteristics Plots, $T_A = 25^\circ\text{C}$ (unless otherwise specified)
Figure 1: Forward Current (I_F) vs. Temperature ($^\circ\text{C}$)

Figure 2: Collector Power Dissipation (P_C) vs. Temperature ($^\circ\text{C}$)

Figure 3: Collector-Emitter Saturation Voltage ($V_{CE(SAT)}$) vs. Forward Current (I_F)

Figure 4: Forward Current (I_F) vs. Forward Voltage (V_F)

Figure 5: Collector Current (I_C) vs. Collector-Emitter Voltage (V_{CE})

Figure 6: Current Transfer Ratio (CTR) vs. Forward Current (I_F)


SDT400-R Performance & Characteristics Plots, $T_A = 25^\circ\text{C}$ (unless otherwise specified)
Figure 7: Relative CTR (%) vs. Temperature ($^\circ\text{C}$)

Figure 8: Collector-Emitter Saturation Voltage ($V_{CE(SAT)}$) vs. Temperature ($^\circ\text{C}$)

Figure 9: Collector Dark Current (I_{CEO}) vs. Temperature ($^\circ\text{C}$)

Figure 10: Response Times vs. Load Resistance (R_L)

Figure 11: Frequency Response Characteristics


SDT400-R Solder Reflow Temperature Profile Recommendations

(1) Infrared Reflow:

Refer to the following figure as an example of an optimal temperature profile for single occurrence infrared reflow. Soldering process should not exceed temperature or time limits expressed herein. Surface temperature of device package should not exceed 250°C:



Process Step	Description	Parameter
A	Preheat Start Temperature (°C)	150°C
B	Preheat Finish Temperature (°C)	180°C
C	Preheat Time (s)	90 - 120s
D	Melting Temperature (°C)	230°C
E	Time above Melting Temperature (s)	30s
F	Peak Temperature, at Terminal (°C)	260°C
G	Dwell Time at Peak Temperature (s)	10s
H	Cool-down (°C/s)	<6°C/s

(2) Wave Solder:

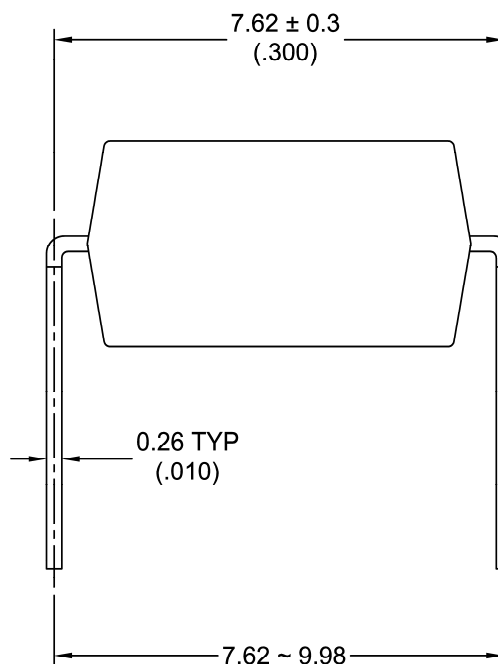
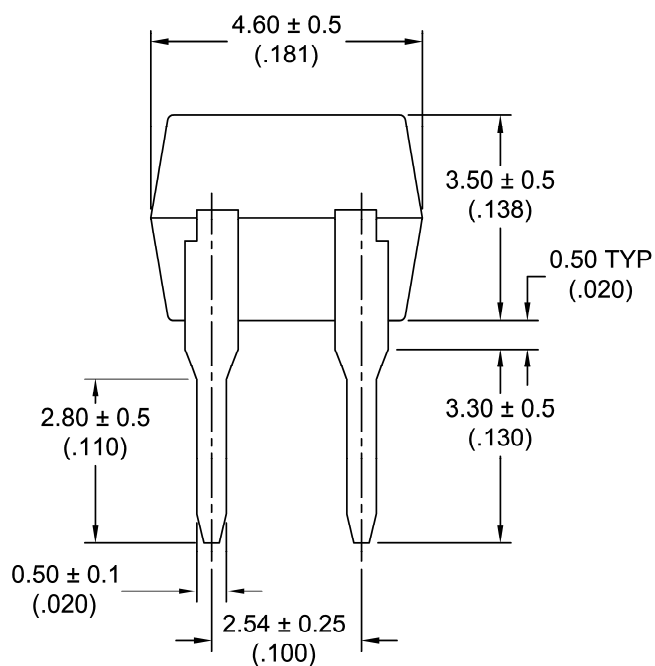
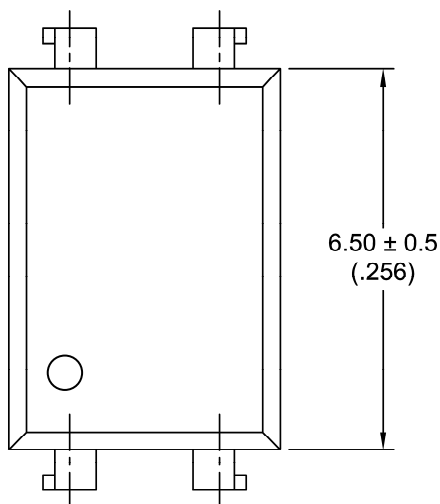
Maximum Temperature: 260°C (at terminal)
 Maximum Time: 10s
 Pre-heating: 100 - 150°C (30 - 90s)
 Single Occurrence

(3) Hand Solder:

Maximum Temperature: 350°C (at tip of soldering iron)
 Maximum Time: 3s
 Single Occurrence

SDT400-R Package Dimensions

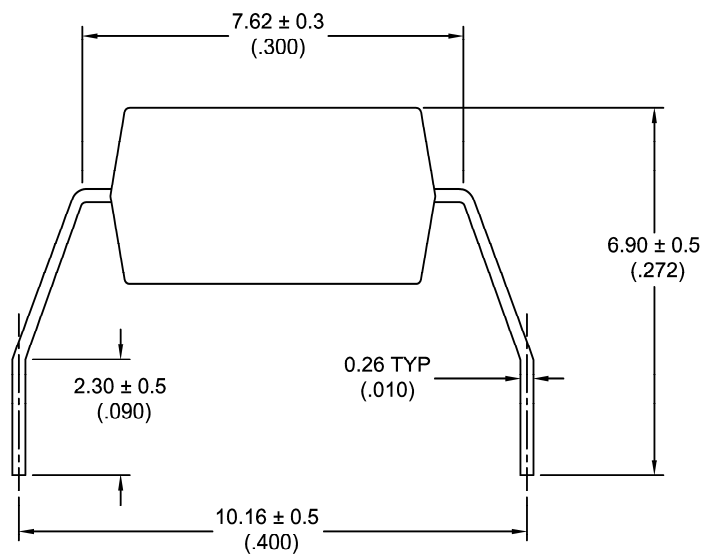
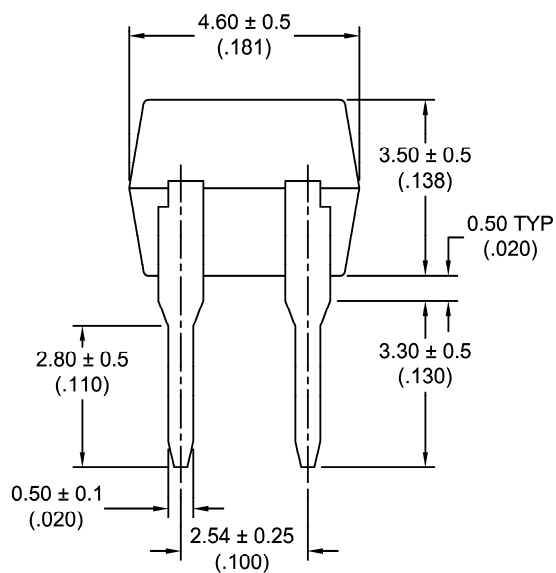
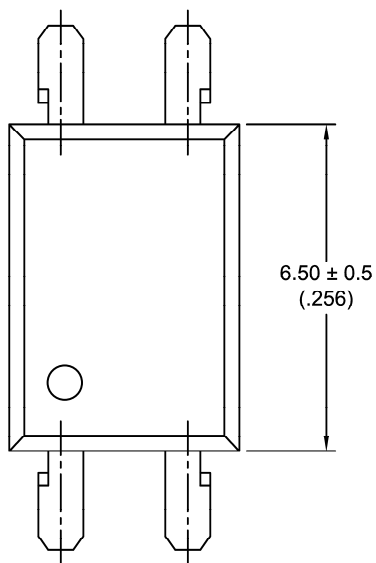
4 PIN DIP Package

Note: All dimensions in millimeters [mm] with inches in parenthesis ()


SDT400-R Package Dimensions

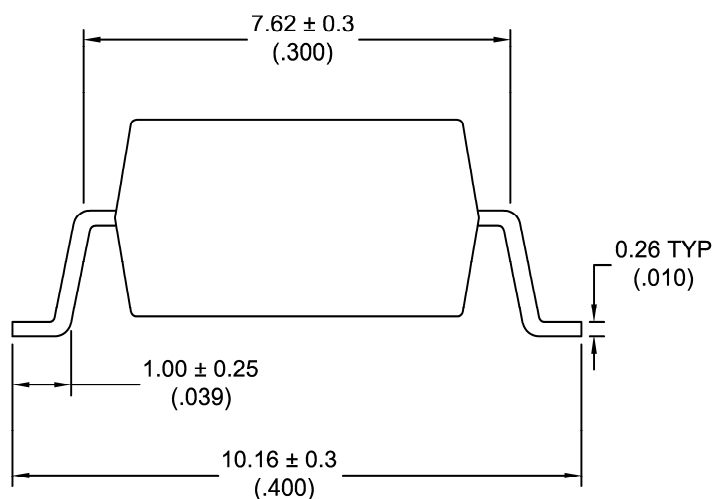
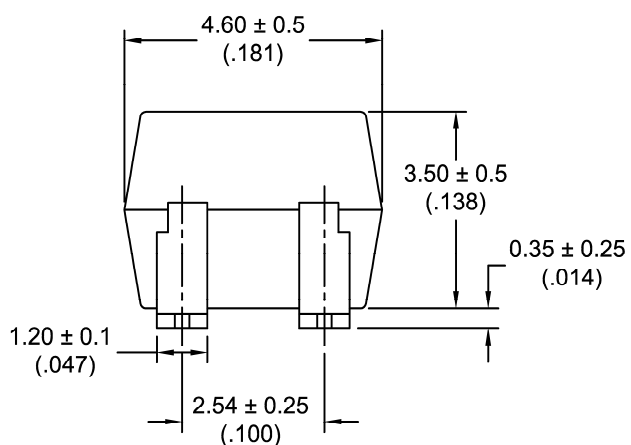
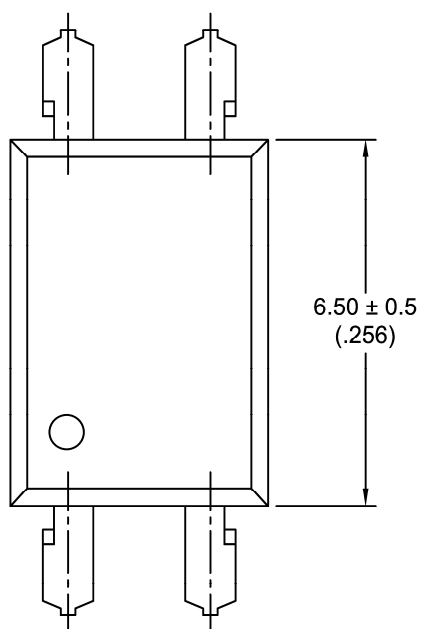
4 PIN WIDE Lead Space Package (-H)

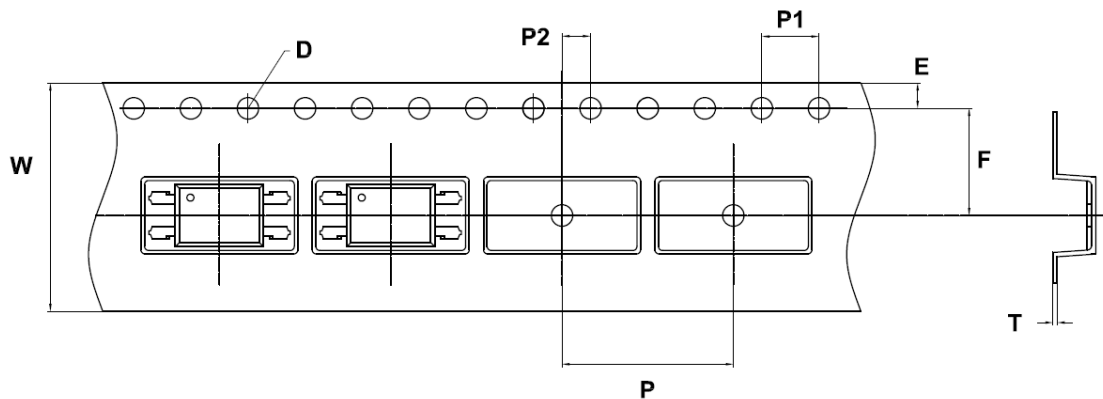
Note: All dimensions in millimeters [mm] with inches in parenthesis ()



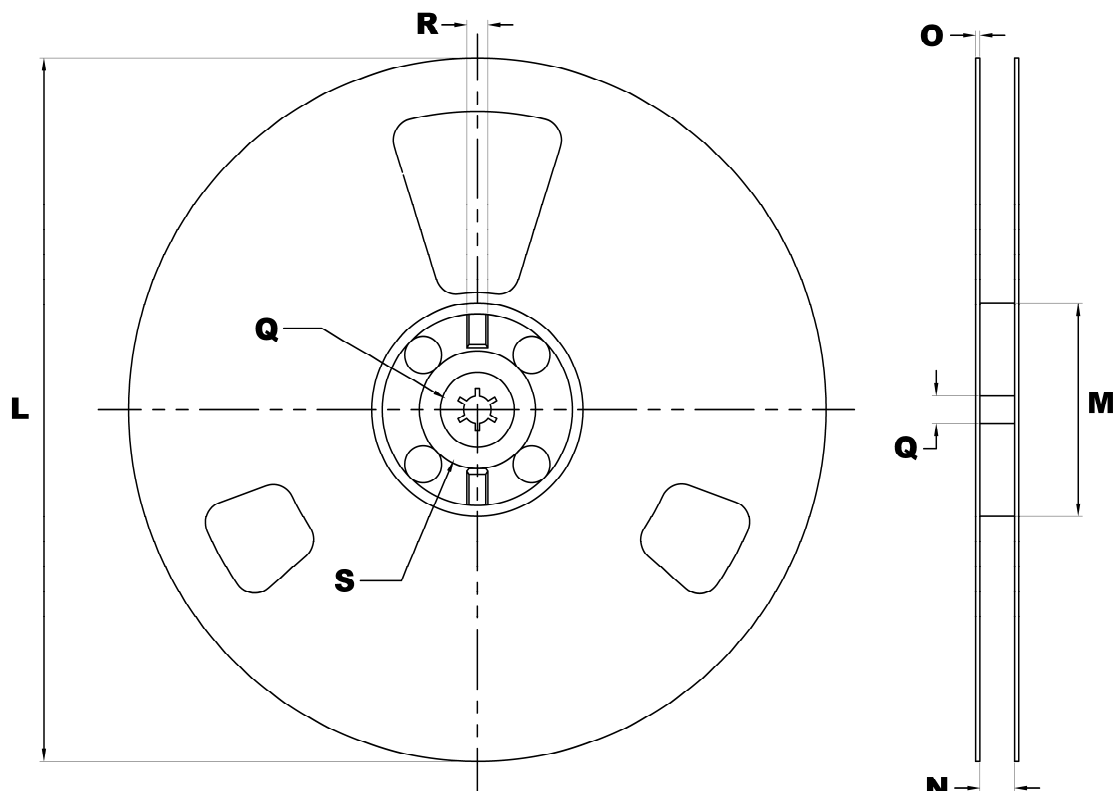
SDT400-R Package Dimensions

4 PIN SMD Surface Mount Package (-S)

Note: All dimensions in millimeters [mm] with inches in parenthesis ()


SDT400-R Packaging Specifications
Tape & Reel Specifications (T&R)
Note: All dimensions in millimeters [mm] with inches in parenthesis ()


D	E	F	P	P1	P2	W	T
1.55±0.05	1.75±0.1	7.5±0.1	12.0±0.1	4.0±0.1	2.0±0.1	16.0±0.3	0.3±0.05



L	M	N	O	Q	R	S
330±2	101.6±1	16.4±0.2	2.0±0.2	R13±0.5	1.50±0.5	R10±1

SDT400-R Ordering Information

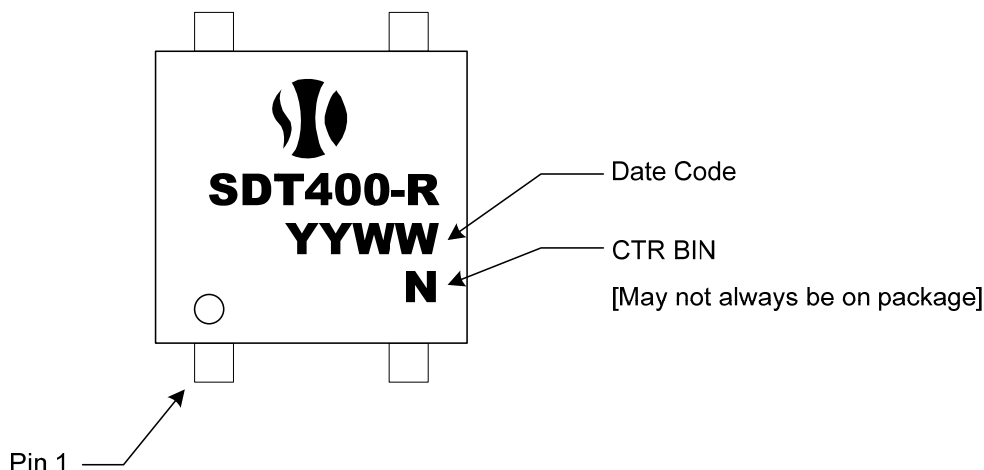
SDT400 – R X Y Z

CTR Binning	
- A	100-400%
- B	100-400%
- C	100-400%
- D	100-400%
- E or Blank	50-600%

VDE Lead Spacing	
- Blank	Standard DIP
- "H"	0.40" Lead Spacing

Packaging / Lead Form	
- Blank	Standard DIP
- S	SMD Form
- STR	SMD + Tape & Reel

SDT400-R Package Marking



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